

**LIST OF PRIOR ART CITED BY  
APPLICANT**  
**(PTO-1449)**

ATTY. DOCKET NO. <b>P-0649</b>	APPLN. SERIAL NO. <b>New U.S. Application</b>
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APPLICANT(S) <b>Hee-La PARK</b>
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CUSTOMER NO. 34610
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FILING DATE <b>April 15, 2004</b>	GROUP <b>art unit</b>
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**U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

**U.S. PATENT APPLICATION PUBLICATIONS**

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	
D.H.	2002/0078228 A1	06/20/2002	Kuisma et al.	709	237	
D.H.	2002/0126708 A1	09/12/2002	Skog et al.	370	522	
D.H.	2002/0087549 A1	07/04/2002	Mostafa	707	10	

**U.S. PATENT APPLICATIONS**

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

**FOREIGN PATENT DOCUMENTS**

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
D.H.	EP 1271970	01/02/2003	EUROPE (Abstract)				
D.H.	JP 2002281550	09/27/2002	JAPAN (Abstract)				
D.H.	WO 0211398	02/07/2002	WIPO (Abstract)				
D.H.	WO 0133781	05/10/2001	WIPO (Abstract)				
D.H.	WO 0133782	05/10/2001	WIPO (Abstract)				

**OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)**


EXAMINER 	DATE CONSIDERED 12/22/2005
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.